## Application/Control No. Applicant(s)/Patent Under Reexamination FARCOT ET AL. Examiner Christopher Bottorff Applicant(s)/Patent Under Reexamination FARCOT ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-1,858,120	05-1932	Stevens	280/607
	В	US-5,261,689	11-1993	Carpenter et al.	280/618
	С	US-5,356,170	10-1994	Carpenter et al.	280/618
	D	US-5,577,755	11-1996	Metzger et al.	280/607
	Е	US-5,765,853	06-1998	Erb	280/607
	F	US-5,791,678	08-1998	Perlman	280/618
	G	US-5,890,729	04-1999	Bayer et al.	280/618
	Н	US-5,909,893	06-1999	Keller et al.	280/607
	ı	US-5,941,552	08-1999	Beran	280/607
	J	US-6,065,768	05-2000	Lee	280/607
	К	US-6,206,402	03-2001	Tanaka	280/607
	L	US-6,386,574	05-2002	Tanaka	280/607
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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